

# TSD60R580WT/TSU60R580WT

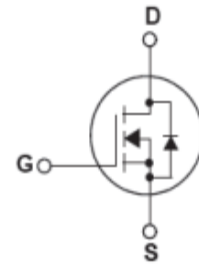
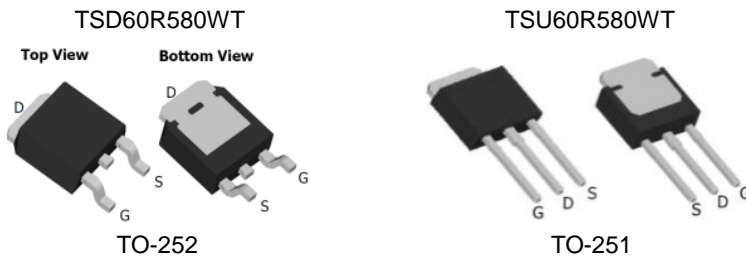
## 600V 7A N-Channel SJ-MOSFET

### General Description

Truesemi SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance. This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

### Features

- 600V @T<sub>J</sub> = 25 °C
- Typ. R<sub>DS(on)</sub> = 0.5Ω
- Ultra Low gate charge (typ. Q<sub>g</sub> = 14.5nC)
- 100% avalanche tested



### Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
V <sub>DSS</sub>	Drain-Source Voltage	600	V
I <sub>D</sub>	Drain Current -Continuous (TC = 25°C)	7	A
I <sub>DM</sub>	Drain Current – Pulsed (Note 1)	21	A
V <sub>GSS</sub>	Gate-Source voltage	±30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	162	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)	1.4	A
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	0.2	mJ
P <sub>D</sub>	Power Dissipation (TC = 25°C)	63	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	Value	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	2.0	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	62	°C/W

## Electrical Characteristics TC = 25°C unless otherwise noted

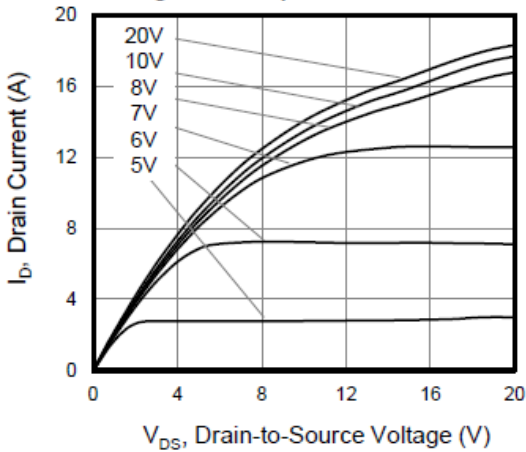
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A, T_J = 25^\circ C$	600	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V, -T_J = 150^\circ C$	--	--	1 100	$\mu A$ $\mu A$
$I_{GSSF}$	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$	--	--	100	nA
$I_{GSSR}$	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V, V_{DS} = 0V$	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.5	--	4.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10V, I_D = 3A$ (Note 3)	--	0.5	0.58	$\Omega$
$g_{FS}$	Forward Trans conductance	$V_{DS} = 10V, I_D = 3A$ (Note 3)	--	0.5	--	S
Dynamic Characteristics						
$C_{iss}$	Input Capacitance	$V_{DS} = 50V, V_{GS} = 0V, f = 1.0MHz$	--	585	--	pF
$C_{oss}$	Output Capacitance		--	32	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	4	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 400V, I_D = 7A, R_G = 25\Omega$	--	40	--	ns
$t_r$	Turn-On Rise Time		--	25	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	100	--	ns
$t_f$	Turn-Off Fall Time		--	17	--	ns
$Q_g$	Total Gate Charge	$V_{DS} = 480V, I_D = 7A, V_{GS} = 10V$	--	14.5	--	nC
$Q_{gs}$	Gate-Source Charge		--	3	--	nC
$Q_{gd}$	Gate-Drain Charge		--	5.3	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current		--	--	6.3	A
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current		--	--	19	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0V, I_F = 7A$	--	0.9	1.2	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0V, I_F = 7A, di_F/dt = 100A/\mu s$	--	250	--	ns
$Q_{rr}$	Reverse Recovery Charge		--	2.1	--	$\mu C$
$I_{rrm}$	Peak Reverse Recovery Current		--	16	--	A

### Notes

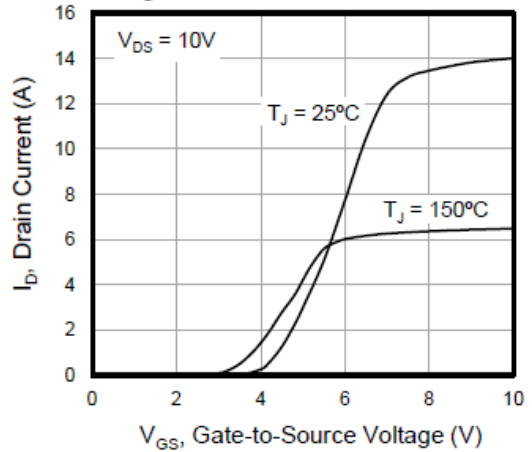
- 1.Repetitive Rating: Pulse width limited by maximum junction temperature
2. $I_{AS} = 1.4A, V_{DD} = 50V, R_G = 25\Omega, \text{Starting } T_J = 25^\circ C$
- 3.Pulse Test: Pulse width  $\leq 300\mu s, \text{Duty Cycle } \leq 1\%$

# Typical Performance Characteristics

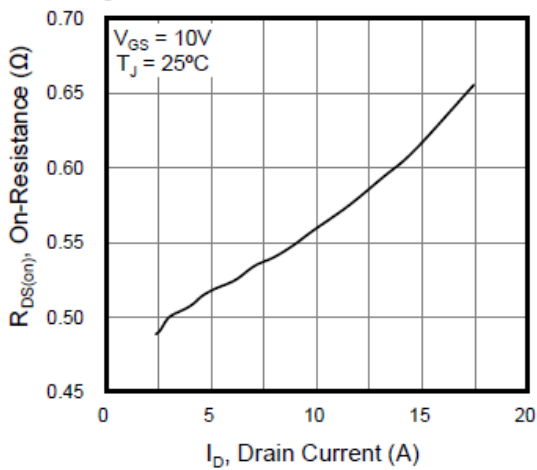
**Figure 1. Output Characteristics**



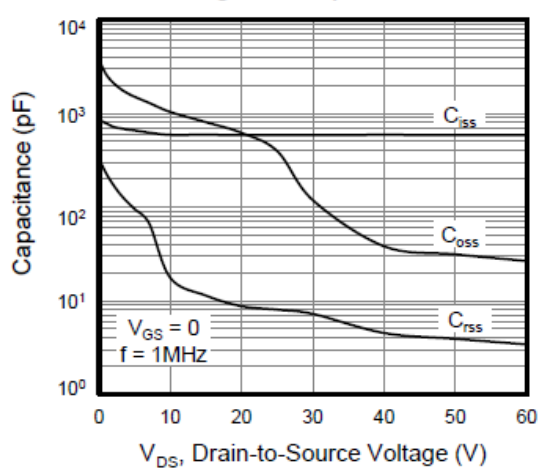
**Figure 2. Transfer Characteristics**



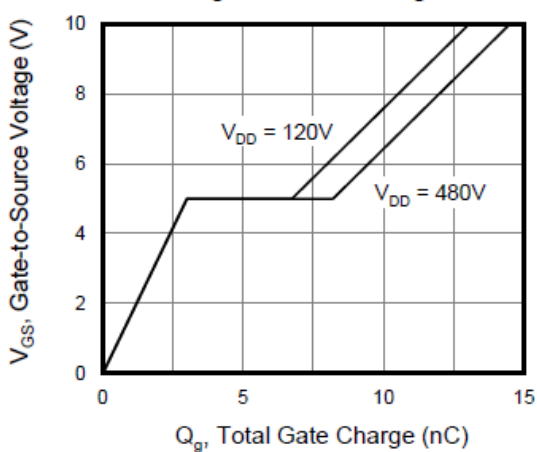
**Figure 3. On-Resistance vs. Drain Current**



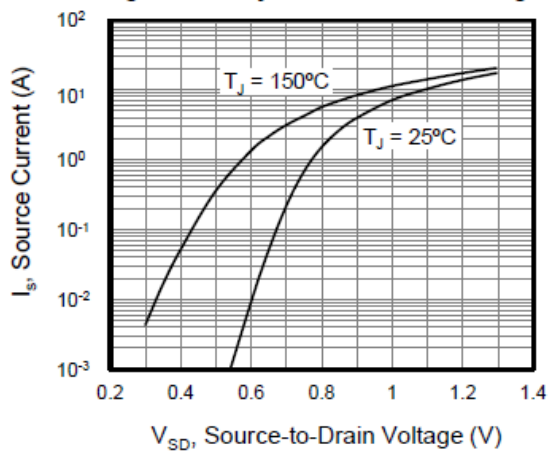
**Figure 4. Capacitance**



**Figure 5. Gate Charge**

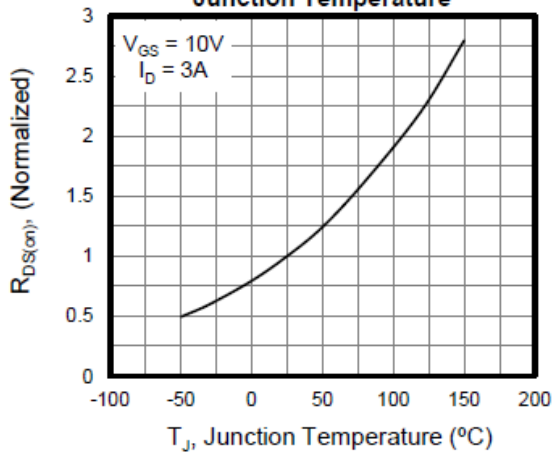


**Figure 6. Body Diode Forward Voltage**

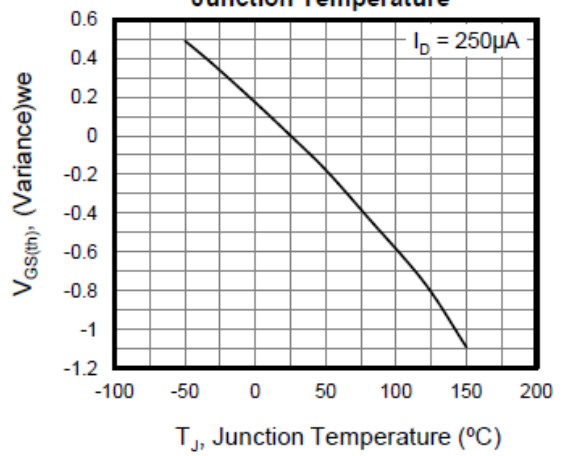


# Typical Performance Characteristics

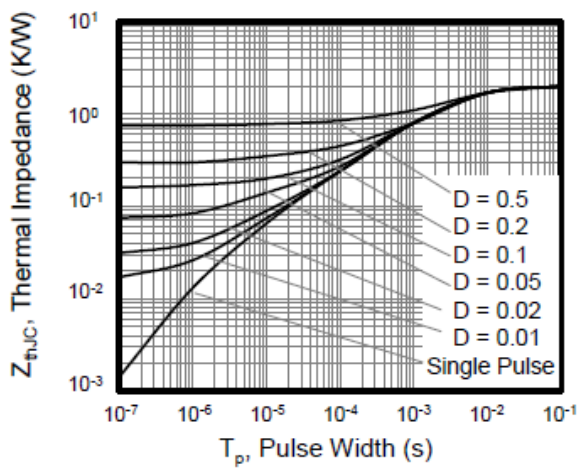
**Figure 7. On-Resistance vs. Junction Temperature**



**Figure 8. Threshold Voltage vs. Junction Temperature**

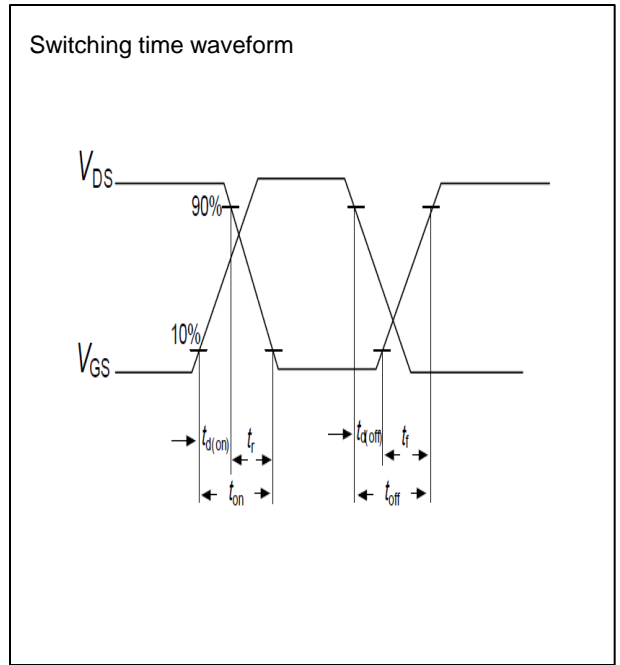
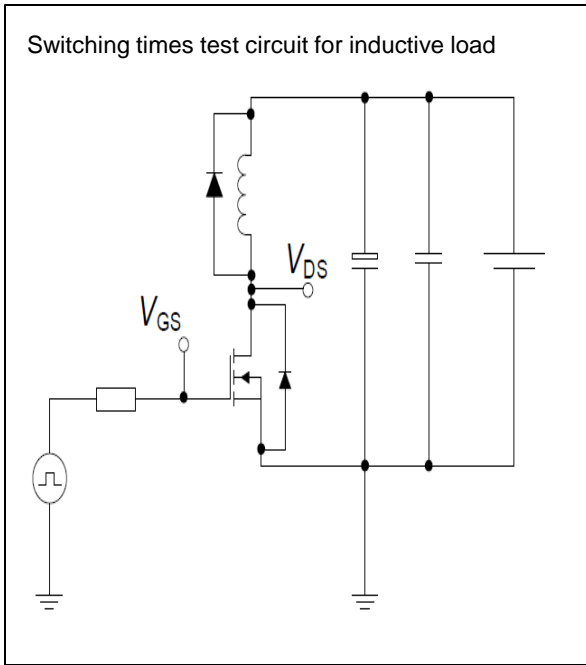


**Figure 9. Transient Thermal Impedance**

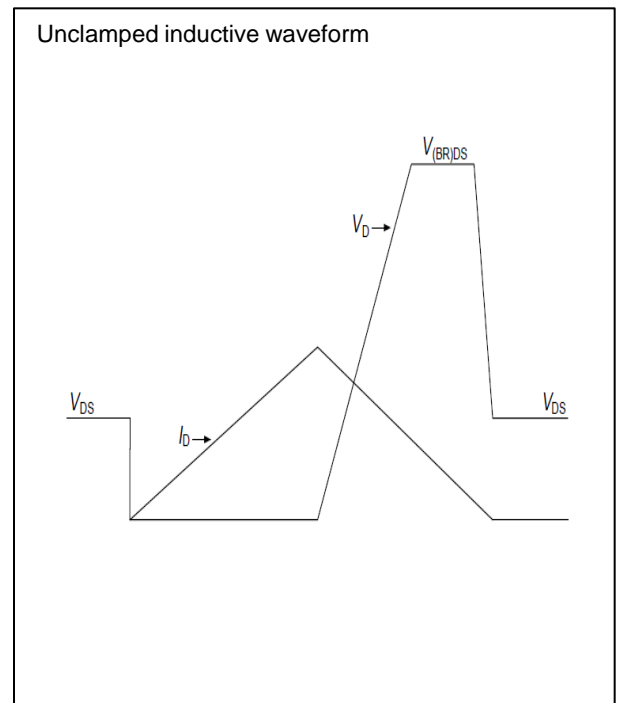
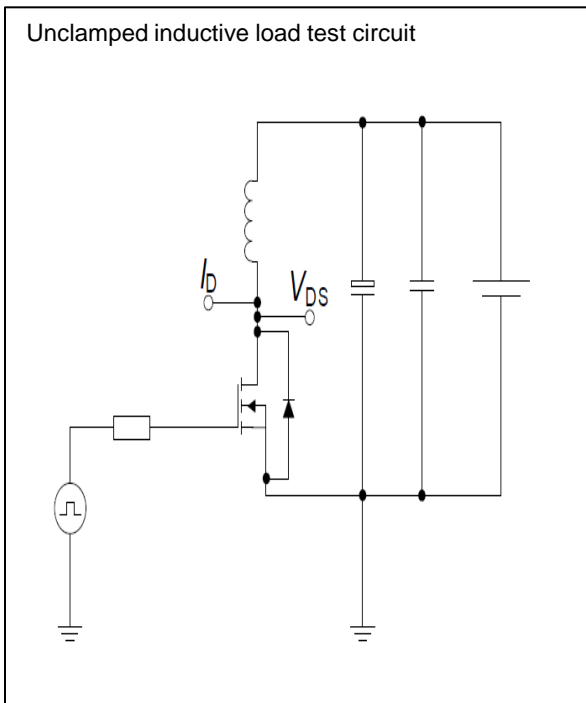


# Test circuits

## Switching times test circuit and waveform for inductive load

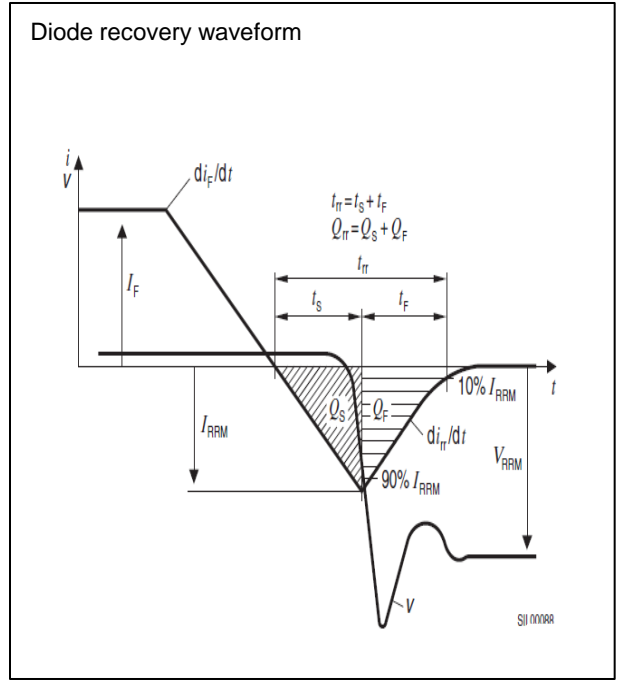
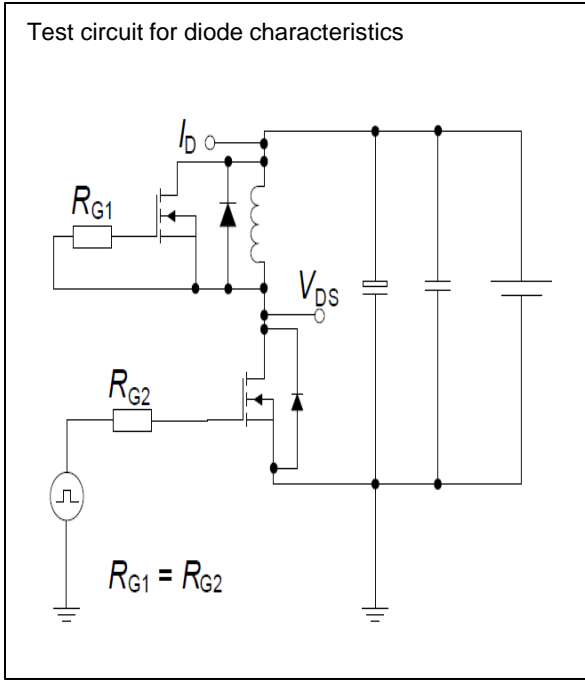


## Unclamped inductive load test circuit and waveform



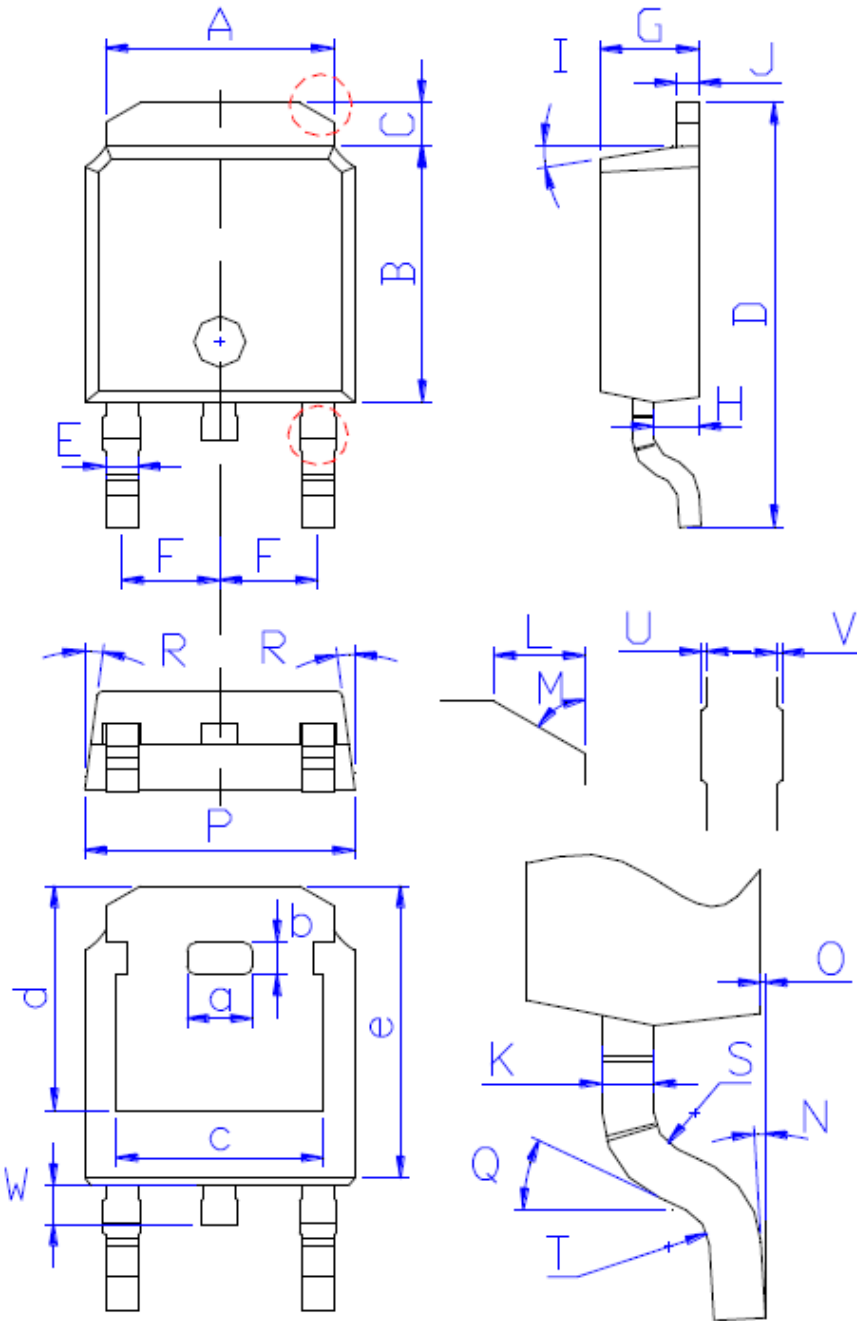
# Test circuits

## Test circuit and waveform for diode characteristics



# Package Outline TO-252

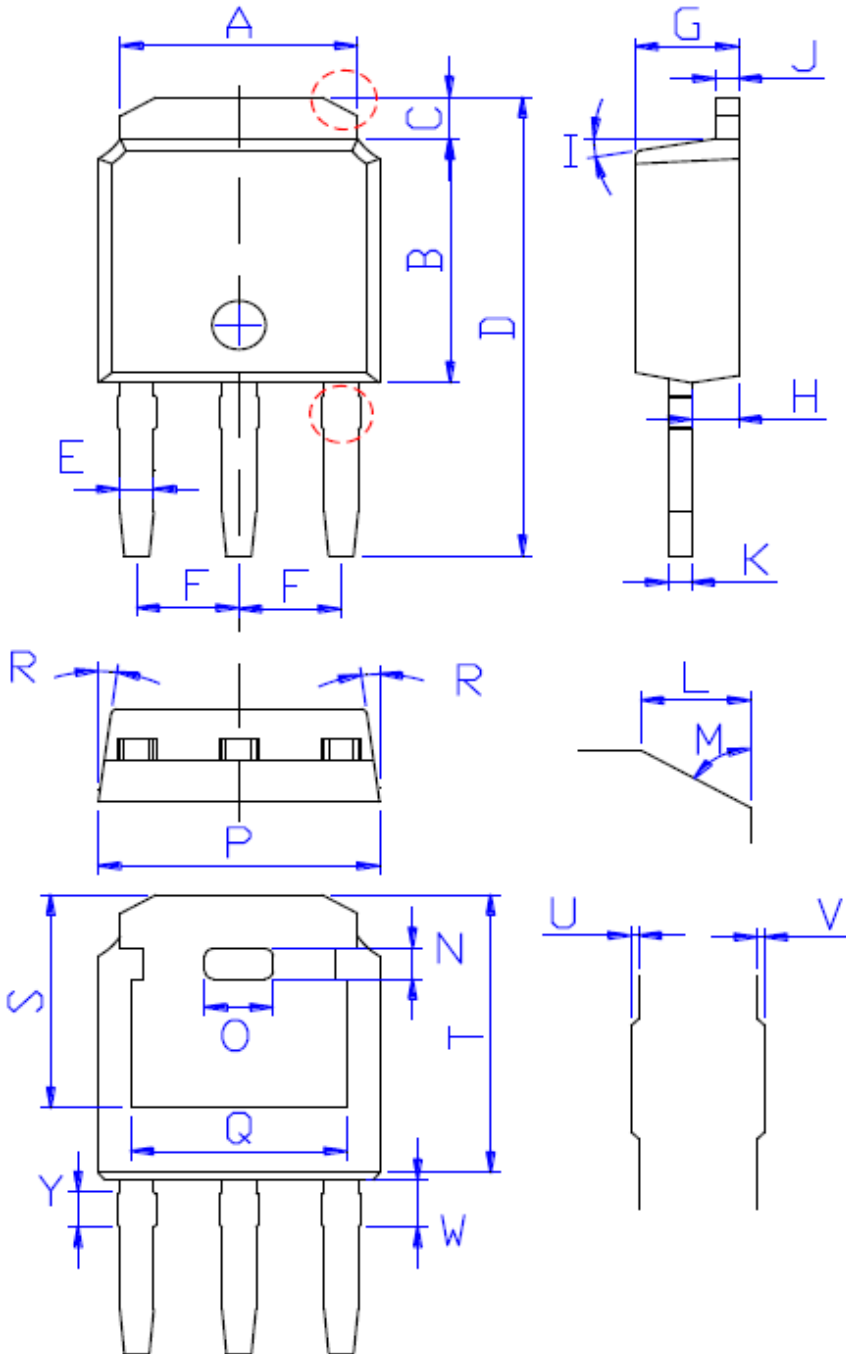
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DIM	MILLIMETERS
A	$5.34 \pm 0.30$
B	$6.00 \pm 0.30$
C	$1.05 \pm 0.30$
D	$9.95 \pm 0.30$
E	$0.76 \pm 0.15$
F	$2.28 \pm 0.15$
G	$2.30 \pm 0.30$
H	$1.06 \pm 0.30$
I	$(4-10)^\circ$
J	$0.51 \pm 0.15$
K	$0.52 \pm 0.15$
L	$0.80 \pm 0.30$
M	$60^\circ$
N	$(0-10)^\circ$
O	$0.05 \pm 0.05$
P	$6.60 \pm 0.30$
Q	$25^\circ$
R	$(4-8.5)^\circ$
S	R0.40
T	R0.40
U	$0.05 \pm 0.05$
V	$0.05 \pm 0.05$
W	$0.90 \pm 0.30$
a	$1.80 \pm 0.30$
b	$0.75 \pm 0.30$
c	$4.85 \pm 0.30$
d	$5.30 \pm 0.30$
e	$6.90 \pm 0.30$

# Package Outline TO-251

TSD60R580WT/TSU60R580WT 600V 7A N-Channel SJ-MOSFET



DIM	MILLIMETERS
A	5.34±0.30
B	6.00±0.30
C	1.05±0.30
D	11.31±0.30
E	0.76±0.15
F	2.28±0.15
G	2.30±0.30
H	1.06±0.30
I	(4-10)°
J	0.51±0.15
K	0.52±0.15
L	0.80±0.30
M	60°
N	0.75±0.30
O	1.80±0.30
P	6.60±0.30
Q	4.85±0.30
R	(4-8.5)°
S	5.30±0.30
T	6.90±0.30
U	0.05±0.05
V	0.05±0.05
W	1.15±0.25
Y	0.85±0.25